


<b>Search Notes</b>  	<b>Application/Control No.</b>  10540669	<b>Applicant(s)/Patent Under Reexamination</b>  VAN DER AA ET AL.
	<b>Examiner</b>  HENOK G HEYI	<b>Art Unit</b>  2627

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Searched EAST and some of the subclasses searched are 369/275.1, 720/718, 600 and 360/99.08 (text search only - please see search history printout).	12/19/2008	HH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/HENOK G HEYI/ Examiner.Art Unit 2627	
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